Se	arch No	otes

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/074,616	GAI ET AL.	
Examiner	Art Unit	
Marc R. Filipczyk	2161	

	SEAR	CHED	
Class	Subclass	Date	Examiner
707	1-10, 100, 200	6/30/2005	MF
711	108	6/30/2005	MF
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INT	INTERFERENCE SEARCHED		
Class	Subclass	Date	Examiner
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DATE 6/30/2005	EXMR MF
6/30/2005	MF
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